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Details

Product Status	Obsolete
Core Processor	HCS12
Core Size	16-Bit
Speed	25MHz
Connectivity	CANbus, EBI/EMI, SCI, SPI
Peripherals	POR, PWM, WDT
Number of I/O	35
Program Memory Size	128KB (128K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	4K x 8
Voltage - Supply (Vcc/Vdd)	2.35V ~ 5.5V
Data Converters	A/D 8x10b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 125°C (TA)
Mounting Type	Surface Mount
Package / Case	52-LQFP
Supplier Device Package	52-TQFP (10x10)
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Chapter 1 MC9S12C and MC9S12GC Device Overview (MC9S12C128)

Address	Name		Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
0v0146		Read:	0	0	0	0	0	TVEO	TVE1	TYEO
0X0140	CANTELG	Write:						INEZ		TAEU
0x0147	CANTIER	Read:	0	0	0	0	0	TXFIF2	TXFIF1	
0,0111	O/ WHEN	Write:								
0x0148	CANTARQ	Read:	0	0	0	0	0	ABTRQ2	ABTRQ1	ABTRQ0
		Write:								
0x0149	CANTAAK	Read:	0	0	0	0	0	ABTAK2	ABTAK1	ABTAK0
	-	Write:								
0x014A	CANTBSEL	Read:	0	0	0	0	0	TX2	TX1	ТХ0
		Write:		-			-			
0x014B	CANIDAC	Read:	0	0	IDAM1	IDAM0	0	IDHIT2	IDHIT1	IDHIT0
		Write:						-		
0x014C	Reserved	Read:	0	0	0	0	0	0	0	0
		Write:	0			0		0	0	
0x014D	Reserved	Read:	0	0	0	0	0	0	0	0
		write:		DVEDDO	DVEDDE			DVEDDO		
0x014E	CANRXERR	Read:	RXERR/	RXERRO	RXERR5	RXERR4	RXERR3	RXERR2	RXERRI	RXERRU
		VVrite:		TYEDDO				TYEDDO		
0x014F	x014F CANTXERR	Read:	IXERR/	IXERRO	IXERRS	IXERR4	IXERR3	IXERR2	IXERRI	TXERRU
0.0150		Pood:								
0x0150-	CANIDARU -	Mrito:	AC7	AC6	AC5	AC4	AC3	AC2	AC1	AC0
0x0150		Pood:								
0x0154-	CANIDMR0 -	Mrito:	AM7	AM6	AM5	AM4	AM3	AM2	AM1	AM0
0,0150		Read:								
0x0156-	CANIDAR4 -	Write	AC7	AC6	AC5	AC4	AC3	AC2	AC1	AC0
0x015C_		Read:								
0x015C=	CANIDMR7	Write:	AM7	AM6	AM5	AM4	AM3	AM2	AM1	AM0
0x0160-	CANRYEG	Read:		FC	REGROUN	ND RECEIV	E BUFFER	see Table 1	-2	·
0x016F	UANNAFG	Write:								
0x0170– 0x017F	CANTXFG	Read: Write:	FOREGROUND TRANSMIT BUFFER see Table 1-2							

0x0140–0x017F CAN (Scalable Controller Area Network — MSCAN)⁽¹⁾ (continued)

1. Not available on the MC9S12GC Family members. Those memory locations should not be accessed.

Table 1-2. Detailed MSCAN Foreground Receive and Transmit Buffer Layout

Address	Name		Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
0xXXX0	Extended ID	Read:	ID28	ID27	ID26	ID25	ID24	ID23	ID22	ID21
	Standard ID	Read:	ID10	ID9	ID8	ID7	ID6	ID5	ID4	ID3
	CANxRIDR0	Write:								
	Extended ID	Read:	ID20	ID19	ID18	SRR=1	IDE=1	ID17	ID16	ID15
0xXXX1	Standard ID	Read:	ID2	ID1	ID0	RTR	IDE=0			
	CANxRIDR1	Write:								



Chapter 2 Port Integration Module (PIM9C32) Block Description

Address	Name		Bit 7	6	5	4	3	2	1	Bit 0
020006	Pacanyad	R	0	0	0	0	0	0	0	0
00000	neserveu	w								
0,0007		R	0	0	0		MODDD2	MODDDO		
0x0007	MODRR	w					MODRR3	MODRR2		MODRRU
		R	0	0	0	0	DTOO	DTOO	DTO1	DTOO
0x0008	PTS	w					P153	P152	P151	P150
		SCI		_	_	_	_	_	TXD	RXD
00000	DTIO	R	0	0	0	0	PTIS3	PTIS2	PTIS1	PTIS0
0x0009	P115	w								
0000		R	0	0	0	0	00000	00000	00004	00000
0X000A	DDRS	w					DDR53	DDR52	DDRSI	DDRSU
		R	0	0	0	0				
0x000B	RDRS	w					RDRS3	RDRS2	RDRS1	RDRS0
		R	0	0	0	0				
0x000C	PERS	w					PERS3	PERS2	PERS1	PERS0
		R	0	0	0	0				
0x000D	PPSS	w					PPSS3	PPSS2	PPSS1	PPSS0
		R	0	0	0	0				
0x000E	WOMS	w					WOMS3	WOMS2	WOMS1	WOMS0
		R	0	0	0	0	0	0	0	0
0x000F	Reserved	w		-			-	-	-	-
		R	0	0						
		w		-	PTM5	PTM4	PTM3	PTM2	PTM1	PTM0
0x0010	PTM	MSCAN								
		/	—	_	SCK	MOSI	SS	MISO	TXCAN	RXCAN
		SPI								
0v0011	DTIM	R	0	0	PTIM5	PTIM4	PTIM3	PTIM2	PTIM1	PTIM0
0,0011	1 1 1111	W								
0v0012	שמח	R	0	0				מאפחח		
0,0012	DDI IM	W			DDI 11VIJ					
0v0013	BUBW	R	0	0		BUBWA		BUBWS		BUBMU
0,0013		W			TIDITIVIS				RURIVII	RUKIVIU
0x0014	DEDM	R	0	0			DEDM3			DEBMO
0,0014		W								
0v0015	PPSM	R	0	0	PPSM5	PPSMA	PPSM3	PPSM2	PPSM1	PPSMO
0,0015	PP3IVI	W				FF3IVI4	FFOIVIO		FFSIVIT	FFSIVIU
0v0016		R	0	0	WOMM5					
010010	VVOIVIIVI	W				VVOIVIIVI4	VVOIVIIVIS			
0,0017	Recorved	R	0	0	0	0	0	0	0	0
UXUU1/ Re	neserveu	W								
		R	PTP7	PTPA	PTP5	ртри	PTD3	ртро	PTD1	PTPA
0x0018	PTP	w								FIFV
		PWM	_	_	PWM5	PWM4	PWM3	PWM2	PWM1	PWM0
020010	סודס	R	PTIP7	PTIP6	PTIP5	PTIP4	PTIP3	PTIP2	PTIP1	PTIP0
020019	FIIP	w								
		ſ]	monted as D	oppresed				
		= Onimplemented of Reserved								

Figure 2-2. Quick Reference to PIM Registers (Sheet 2 of 3)



Chapter 2 Port Integration Module (PIM9C32) Block Description

2.3.2.5.7 Port J Interrupt Enable Register (PIEJ)





Figure 2-38. Port J Interrupt Enable Register (PIEJ)

Read: Anytime.

Write: Anytime.

Field	Description
7–6 PIEJ[7:6]	 Interrupt Enable Port J — This register disables or enables on a per pin basis the edge sensitive external interrupt associated with port J. 0 Interrupt is disabled (interrupt flag masked). 1 Interrupt is enabled.

2.3.2.5.8 Port J Interrupt Flag Register (PIFJ)

Module Base + 0x002F



Figure 2-39. Port J Interrupt Flag Register (PIFJ)

Read: Anytime.

Write: Anytime.

Table 2-33. PIFJ Field Descriptions

Field	Description
7–6 PIFJ[7:6]	 Interrupt Flags Port J — Each flag is set by an active edge on the associated input pin. This could be a rising or a falling edge based on the state of the PPSJ register. To clear this flag, write "1" to the corresponding bit in the PIFJ register. Writing a "0" has no effect. 0 No active edge pending. Writing a "0" has no effect. 1 Active edge on the associated bit has occurred (an interrupt will occur if the associated enable bit is set). Writing a "1" clears the associated flag.



Pin Name	Pin Functions	Description
BKGD/MODC/ TAGHI	MODC	At the rising edge on RESET, the state of this pin is registered into the MODC bit to set the mode. (This pin always has an internal pullup.)
	BKGD	Pseudo open-drain communication pin for the single-wire background debug mode. There is an internal pull-up resistor on this pin.
	TAGHI	When instruction tagging is on, a 0 at the falling edge of E tags the high half of the instruction word being read into the instruction queue.
PA7/A15/D15/D7	PA7-PA0	General-purpose I/O pins, see PORTA and DDRA registers.
thru PA0/A8/D8/D0	A15–A8	High-order address lines multiplexed during ECLK low. Outputs except in special peripheral mode where they are inputs from an external tester system.
	D15–D8	High-order bidirectional data lines multiplexed during ECLK high in expanded wide modes, special peripheral mode, and visible internal accesses (IVIS = 1) in emulation expanded narrow mode. Direction of data transfer is generally indicated by R/\overline{W} .
	D15/D7 thru D8/D0	Alternate high-order and low-order bytes of the bidirectional data lines multiplexed during ECLK high in expanded narrow modes and narrow accesses in wide modes. Direction of data transfer is generally indicated by R/W.
PB7/A7/D7	PB7–PB0	General-purpose I/O pins, see PORTB and DDRB registers.
PB0/A0/D0	A7–A0	Low-order address lines multiplexed during ECLK low. Outputs except in special peripheral mode where they are inputs from an external tester system.
	D7–D0	Low-order bidirectional data lines multiplexed during ECLK high in expanded wide modes, special peripheral mode, and visible internal accesses (with $IVIS = 1$) in emulation expanded narrow mode. Direction of data transfer is generally indicated by R/\overline{W} .
PE7/NOACC	PE7	General-purpose I/O pin, see PORTE and DDRE registers.
	NOACC	CPU No Access output. Indicates whether the current cycle is a free cycle. Only available in expanded modes.
PE6/IPIPE1/ MODB/CLKTO	MODB	At the rising edge of $\overline{\text{RESET}}$, the state of this pin is registered into the MODB bit to set the mode.
	PE6	General-purpose I/O pin, see PORTE and DDRE registers.
	IPIPE1	Instruction pipe status bit 1, enabled by PIPOE bit in PEAR.
	СLКТО	System clock test output. Only available in special modes. PIPOE = 1 overrides this function. The enable for this function is in the clock module.
PE5/IPIPE0/MODA	MODA	At the rising edge on RESET, the state of this pin is registered into the MODA bit to set the mode.
	PE5	General-purpose I/O pin, see PORTE and DDRE registers.
	IPIPE0	Instruction pipe status bit 0, enabled by PIPOE bit in PEAR.



Chapter 4 Multiplexed External Bus Interface (MEBIV3)

4.3.2.16 Port K Data Direction Register (DDRK)

Module Base + 0x0033

Starting address location affected by INITRG register setting.



Read: Anytime

Write: Anytime

This register determines the primary direction for each port K pin configured as general-purpose I/O. This register is not in the map in peripheral or expanded modes while the EMK control bit in MODE register is set. Therefore, these accesses will be echoed externally.

Field	Description
7:0 DDRK	Data Direction Port K Bits 0 Associated pin is a high-impedance input
	 Associated pin is an output Note: It is unwise to write PORTK and DDRK as a word access. If you are changing port K pins from inputs to outputs, the data may have extra transitions during the write. It is best to initialize PORTK before enabling as outputs.
	Note: To ensure that you read the correct value from the PORTK pins, always wait at least one cycle after writing to the DDRK register before reading from the PORTK register.

4.4 Functional Description

4.4.1 Detecting Access Type from External Signals

The external signals $\overline{\text{LSTRB}}$, R/\overline{W} , and AB0 indicate the type of bus access that is taking place. Accesses to the internal RAM module are the only type of access that would produce $\overline{\text{LSTRB}} = \text{AB0} = 1$, because the internal RAM is specifically designed to allow misaligned 16-bit accesses in a single cycle. In these cases the data for the address that was accessed is on the low half of the data bus and the data for address + 1 is on the high half of the data bus. This is summarized in Table 4-15.

LSTRB	AB0	R/W	Type of Access
1	0	1	8-bit read of an even address
0	1	1	8-bit read of an odd address
1	0	0	8-bit write of an even address
0	1	0	8-bit write of an odd address



Chapter 7 Debug Module (DBGV1) Block Description

7.4.2.3 Begin- and End-Trigger

The definitions of begin- and end-trigger as used in the DBG module are as follows:

- Begin-trigger: Storage in trace buffer occurs after the trigger and continues until 64 locations are filled.
- End-trigger: Storage in trace buffer occurs until the trigger, with the least recent data falling out of the trace buffer if more than 64 words are collected.

7.4.2.4 Arming the DBG Module

In DBG mode, arming occurs by setting DBGEN and ARM in DBGC1. The ARM bit in DBGC1 is cleared when the trigger condition is met in end-trigger mode or when the Trace Buffer is filled in begin-trigger mode. The TBC logic determines whether a trigger condition has been met based on the trigger mode and the trigger selection.

7.4.2.5 Trigger Modes

The DBG module supports nine trigger modes. The trigger modes are encoded as shown in Table 7-6. The trigger mode is used as a qualifier for either starting or ending the storing of data in the trace buffer. When the match condition is met, the appropriate flag A or B is set in DBGSC. Arming the DBG module clears the A, B, and C flags in DBGSC. In all trigger modes except for the event-only modes and DETAIL capture mode, change-of-flow addresses are stored in the trace buffer. In the event-only modes only the value on the data bus at the trigger event B will be stored. In DETAIL capture mode address and data for all cycles except program fetch (P) and free (f) cycles are stored in trace buffer.

7.4.2.5.1 A Only

In the A only trigger mode, if the match condition for A is met, the A flag in DBGSC is set and a trigger occurs.

7.4.2.5.2 A or B

In the A or B trigger mode, if the match condition for A or B is met, the corresponding flag in DBGSC is set and a trigger occurs.

7.4.2.5.3 A then B

In the A then B trigger mode, the match condition for A must be met before the match condition for B is compared. When the match condition for A or B is met, the corresponding flag in DBGSC is set. The trigger occurs only after A then B have matched.

NOTE

When tagging and using A then B, if addresses A and B are close together, then B may not complete the trigger sequence. This occurs when A and B are in the instruction queue at the same time. Basically the A trigger has not yet occurred, so the B instruction is not tagged. Generally, if address B is at



7.4.2.6 Capture Modes

The DBG in DBG mode can operate in four capture modes. These modes are described in the following subsections.

7.4.2.6.1 Normal Mode

In normal mode, the DBG module uses comparator A and B as triggering devices. Change-of-flow information or data will be stored depending on TRG in DBGSC.

7.4.2.6.2 Loop1 Mode

The intent of loop1 mode is to prevent the trace buffer from being filled entirely with duplicate information from a looping construct such as delays using the DBNE instruction or polling loops using BRSET/BRCLR instructions. Immediately after address information is placed in the trace buffer, the DBG module writes this value into the C comparator and the C comparator is placed in ignore address mode. This will prevent duplicate address entries in the trace buffer resulting from repeated bit-conditional branches. Comparator C will be cleared when the ARM bit is set in loop1 mode to prevent the previous contents of the register from interfering with loop1 mode operation. Breakpoints based on comparator C are disabled.

Loop1 mode only inhibits duplicate source address entries that would typically be stored in most tight looping constructs. It will not inhibit repeated entries of destination addresses or vector addresses, because repeated entries of these would most likely indicate a bug in the user's code that the DBG module is designed to help find.

NOTE

In certain very tight loops, the source address will have already been fetched again before the C comparator is updated. This results in the source address being stored twice before further duplicate entries are suppressed. This condition occurs with branch-on-bit instructions when the branch is fetched by the first P-cycle of the branch or with loop-construct instructions in which the branch is fetched with the first or second P cycle. See examples below:

LOOP	INCX BRCLR	CMPTMP,#\$0c,LOOP	; ;	1-byte instruction fetched by 1st P-cycle of BRCLR the BRCLR instruction also will be fetched by 1st P-cycle of BRCLR
LOOP2	BRN NOP	*	;;	2-byte instruction fetched by 1st P-cycle of DBNE 1-byte instruction fetched by 2nd P-cycle of DBNE
	DBNE	A,LOOP2	;	this instruction also fetched by 2nd P-cycle of DBNE

NOTE

Loop1 mode does not support paged memory, and inhibits duplicate entries in the trace buffer based solely on the CPU address. There is a remote possibility of an erroneous address match if program flow alternates between paged and unpaged memory space.





9.4.2 System Clocks Generator

Figure 9-17. System Clocks Generator

The clock generator creates the clocks used in the MCU (see Figure 9-17). The gating condition placed on top of the individual clock gates indicates the dependencies of different modes (stop, wait) and the setting of the respective configuration bits.

The peripheral modules use the bus clock. Some peripheral modules also use the oscillator clock. The memory blocks use the bus clock. If the MCU enters self-clock mode (see Section 9.4.7.2, "Self-Clock Mode"), oscillator clock source is switched to PLLCLK running at its minimum frequency f_{SCM} . The bus clock is used to generate the clock visible at the ECLK pin. The core clock signal is the clock for the CPU. The core clock is twice the bus clock as shown in Figure 9-18. But note that a CPU cycle corresponds to one bus clock.

PLL clock mode is selected with PLLSEL bit in the CLKSEL register. When selected, the PLL output clock drives SYSCLK for the main system including the CPU and peripherals. The PLL cannot be turned off by clearing the PLLON bit, if the PLL clock is selected. When PLLSEL is changed, it takes a maximum



СМЕ	SCME	SCMIE	CRG Actions			
0	х	х	Clock failure> No action, clock loss not detected.			
1	0	Х	Clock failure> CRG performs Clock Monitor Reset immediately			
1	1	0	Clock failure>			
			Scenario 1: OSCCLK recovers prior to exiting Wait Mode. – MCU remains in Wait Mode, – VREG enabled, – PLL enabled, – SCM activated, – Start Clock Quality Check, – Set SCMIF interrupt flag.			
			Some time later OSCCLK recovers.			
			 CM no longer indicates a failure, 4096 OSCCLK cycles later Clock Quality Check indicates clock o.k., SCM deactivated, PLL disabled depending on PLLWAI, VREG remains enabled <i>(never gets disabled in Wait Mode)</i>. MCU remains in Wait Mode. 			
			Some time later either a wakeup interrupt occurs (no SCM interrupt) – Exit Wait Mode using OSCCLK as system clock (SYSCLK), – Continue normal operation.			
			or an External Reset is applied. – Exit Wait Mode using OSCCLK as system clock, – Start reset sequence.			
			Scenario 2: OSCCLK does not recover prior to exiting Wait Mode. – MCU remains in Wait Mode, – VREG enabled, – PLL enabled, – SCM activated, – Start Clock Quality Check, – Set SCMIF interrupt flag, – Keep performing Clock Quality Checks (could continue infinitely) while in Wait Mode.			
			 Some time later either a wakeup interrupt occurs (no SCM interrupt) – Exit Wait Mode in SCM using PLL clock (f_{SCM}) as system clock, – Continue to perform additional Clock Quality Checks until OSCCLK is o.k. again. 			
			or an External RESET is applied. – Exit Wait Mode in SCM using PLL clock (f _{SCM}) as system clock, – Start reset sequence, – Continue to perform additional Clock Quality Checks until OSCCLK is o.k.again.			



CME	SCME	SCMIE	CRG Actions
1	1	1	Clock failure> - VREG enabled, - PLL enabled, - SCM activated, - Start Clock Quality Check, - SCMIF set. SCMIF generates Self-Clock Mode wakeup interrupt. - Exit Wait Mode in SCM using PLL clock (f _{SCM}) as system clock, - Continue to perform a additional Clock Quality Checks until OSCCLK is o.k. again.

Table 9-11. Outcome of Clock Loss in Wait Mode (continued)

9.4.10 Low-Power Operation in Stop Mode

All clocks are stopped in STOP mode, dependent of the setting of the PCE, PRE and PSTP bit. The oscillator is disabled in STOP mode unless the PSTP bit is set. All counters and dividers remain frozen but do not initialize. If the PRE or PCE bits are set, the RTI or COP continues to run in pseudo-stop mode. In addition to disabling system and core clocks the CRG requests other functional units of the MCU (e.g. voltage-regulator) to enter their individual power-saving modes (if available). This is the main difference between pseudo-stop mode and wait mode.

After executing the STOP instruction the core requests the CRG to switch the MCU into stop mode. If the PLLSEL bit remains set when entering stop mode, the CRG will switch the system and core clocks to OSCCLK by clearing the PLLSEL bit. Then the CRG disables the PLL, disables the core clock and finally disables the remaining system clocks. As soon as all clocks are switched off, stop mode is active.

If pseudo-stop mode (PSTP = 1) is entered from self-clock mode the CRG will continue to check the clock quality until clock check is successful. The PLL and the voltage regulator (VREG) will remain enabled. If full stop mode (PSTP = 0) is entered from self-clock mode an ongoing clock quality check will be stopped. A complete timeout window check will be started when stop mode is exited again.

Wake-up from stop mode also depends on the setting of the PSTP bit.



Chapter 9 Clocks and Reset Generator (CRGV4) Block Description

The internal reset of the MCU remains asserted while the reset generator completes the 192 SYSCLK long reset sequence. The reset generator circuitry always makes sure the internal reset is deasserted synchronously after completion of the 192 SYSCLK cycles. In case the RESET pin is externally driven low for more than these 192 SYSCLK cycles (external reset), the internal reset remains asserted too.



9.5.1 Clock Monitor Reset

The CRGV4 generates a clock monitor reset in case all of the following conditions are true:

- Clock monitor is enabled (CME=1)
- Loss of clock is detected
- Self-clock mode is disabled (SCME=0)

The reset event asynchronously forces the configuration registers to their default settings (see Section 9.3, "Memory Map and Register Definition"). In detail the CME and the SCME are reset to logical '1' (which doesn't change the state of the CME bit, because it has already been set). As a consequence, the CRG immediately enters self-clock mode and starts its internal reset sequence. In parallel the clock quality check starts. As soon as clock quality check indicates a valid oscillator clock the CRG switches to OSCCLK and leaves self-clock mode. Because the clock quality checker is running in parallel to the reset generator, the CRG may leave self-clock mode while completing the internal reset sequence. When the reset sequence is finished the CRG checks the internally latched state of the clock monitor fail circuit. If a clock monitor fail is indicated processing begins by fetching the clock monitor reset vector.

9.5.2 Computer Operating Properly Watchdog (COP) Reset

When COP is enabled, the CRG expects sequential write of 0x0055 and 0x00AA (in this order) to the ARMCOP register during the selected time-out period. As soon as this is done, the COP time-out period restarts. If the program fails to do this the CRG will generate a reset. Also, if any value other than 0x0055 or 0x00AA is written, the CRG immediately generates a reset. In case windowed COP operation is enabled



10.3.2.12 MSCAN Identifier Acceptance Control Register (CANIDAC)

The CANIDAC register is used for identifier acceptance control as described below.





Read: Anytime

Write: Anytime in initialization mode (INITRQ = 1 and INITAK = 1), except bits IDHITx, which are read-only

Table 10-16		Register Field	Descriptions
-------------	--	-----------------------	--------------

Field	Description
5:4 IDAM[1:0]	Identifier Acceptance Mode — The CPU sets these flags to define the identifier acceptance filter organization (see Section 10.4.3, "Identifier Acceptance Filter"). Table 10-17 summarizes the different settings. In filter closed mode, no message is accepted such that the foreground buffer is never reloaded.
2:0 IDHIT[2:0]	Identifier Acceptance Hit Indicator — The MSCAN sets these flags to indicate an identifier acceptance hit (see Section 10.4.3, "Identifier Acceptance Filter"). Table 10-18 summarizes the different settings.

Table 10-17. Identifier Acceptance Mode Settings

IDAM1	IDAM0	Identifier Acceptance Mode				
0	0	Two 32-bit acceptance filters				
0	1	Four 16-bit acceptance filters				
1	0	Eight 8-bit acceptance filters				
1	1	Filter closed				

Table 10-18. Identifier Acceptance Hit Indication

IDHIT2	IDHIT1	IDHIT0	Identifier Acceptance Hit		
0	0	0	Filter 0 hit		
0	0	1 Filter 1 hit			
0	1	0	Filter 2 hit		
0	1	1	Filter 3 hit		
1	0	0	Filter 4 hit		
1	0	1	Filter 5 hit		
1	1	0	Filter 6 hit		
1	1	1	Filter 7 hit		



Chapter 13 Serial Communications Interface (S12SCIV2) Block Description

Table 13-3. Loop Functions

LOOPS	RSRC	Function		
0	x	Normal operation		
1	0	Loop mode with Rx input internally connected to Tx output		
1	1	Single-wire mode with Rx input connected to TXD		

13.3.2.3 SCI Control Register 2 (SCICR2)

Module Base + 0x_0003



Read: Anytime

Write: Anytime

Table 13-4. SCICR2 Field Descriptions

Field	Description
7 TIE	 Transmitter Interrupt Enable Bit — TIE enables the transmit data register empty flag, TDRE, to generate interrupt requests. 0 TDRE interrupt requests disabled 1 TDRE interrupt requests enabled
6 TCIE	 Transmission Complete Interrupt Enable Bit — TCIE enables the transmission complete flag, TC, to generate interrupt requests. 0 TC interrupt requests disabled 1 TC interrupt requests enabled
5 RIE	 Receiver Full Interrupt Enable Bit — RIE enables the receive data register full flag, RDRF, or the overrun flag, OR, to generate interrupt requests. 0 RDRF and OR interrupt requests disabled 1 RDRF and OR interrupt requests enabled
4 ILIE	 Idle Line Interrupt Enable Bit — ILIE enables the idle line flag, IDLE, to generate interrupt requests. IDLE interrupt requests disabled IDLE interrupt requests enabled
3 TE	Transmitter Enable Bit — TE enables the SCI transmitter and configures the TXD pin as being controlled by the SCI. The TE bit can be used to queue an idle preamble. 0 Transmitter disabled 1 Transmitter enabled
2 RE	Receiver Enable Bit — RE enables the SCI receiver. 0 Receiver disabled 1 Receiver enabled



13.4.5 Single-Wire Operation

Normally, the SCI uses two pins for transmitting and receiving. In single-wire operation, the RXD pin is disconnected from the SCI. The SCI uses the TXD pin for both receiving and transmitting.



Figure 13-22. Single-Wire Operation (LOOPS = 1, RSRC = 1)

Enable single-wire operation by setting the LOOPS bit and the receiver source bit, RSRC, in SCI control register 1 (SCICR1). Setting the LOOPS bit disables the path from the **Rx Input** signal to the receiver. Setting the RSRC bit connects the receiver input to the output of the TXD pin driver. Both the transmitter and receiver must be enabled (TE = 1 and RE = 1). The TXDIR bit (SCISR2[1]) determines whether the TXD pin is going to be used as an input (TXDIR = 0) or an output (TXDIR = 1) in this mode of operation.

13.4.6 Loop Operation

In loop operation the transmitter output goes to the receiver input. The **Rx Input** signal is disconnected from the SCI



Figure 13-23. Loop Operation (LOOPS = 1, RSRC = 0)

Enable loop operation by setting the LOOPS bit and clearing the RSRC bit in SCI control register 1 (SCICR1). Setting the LOOPS bit disables the path from the **Rx Input** signal to the receiver. Clearing the RSRC bit connects the transmitter output to the receiver input. Both the transmitter and receiver must be enabled (TE = 1 and RE = 1).

13.5 Initialization Information

13.5.1 Reset Initialization

The reset state of each individual bit is listed in Section 13.3, "Memory Map and Registers" which details the registers and their bit fields. All special functions or modes which are initialized during or just following reset are described within this section.



Chapter 14 Serial Peripheral Interface (SPIV3) Block Description

SPPR2	SPPR1	SPPR0	SPR2	SPR1	SPR0	Baud Rate Divisor	Baud Rate
0	0	0	0	0	0	2	12.5 MHz
0	0	0	0	0	1	4	6.25 MHz
0	0	0	0	1	0	8	3.125 MHz
0	0	0	0	1	1	16	1.5625 MHz
0	0	0	1	0	0	32	781.25 kHz
0	0	0	1	0	1	64	390.63 kHz
0	0	0	1	1	0	128	195.31 kHz
0	0	0	1	1	1	256	97.66 kHz
0	0	1	0	0	0	4	6.25 MHz
0	0	1	0	0	1	8	3.125 MHz
0	0	1	0	1	0	16	1.5625 MHz
0	0	1	0	1	1	32	781.25 kHz
0	0	1	1	0	0	64	390.63 kHz
0	0	1	1	0	1	128	195.31 kHz
0	0	1	1	1	0	256	97.66 kHz
0	0	1	1	1	1	512	48.83 kHz
0	1	0	0	0	0	6	4.16667 MHz
0	1	0	0	0	1	12	2.08333 MHz
0	1	0	0	1	0	24	1.04167 MHz
0	1	0	0	1	1	48	520.83 kHz
0	1	0	1	0	0	96	260.42 kHz
0	1	0	1	0	1	192	130.21 kHz
0	1	0	1	1	0	384	65.10 kHz
0	1	0	1	1	1	768	32.55 kHz
0	1	1	0	0	0	8	3.125 MHz
0	1	1	0	0	1	16	1.5625 MHz
0	1	1	0	1	0	32	781.25 kHz
0	1	1	0	1	1	64	390.63 kHz
0	1	1	1	0	0	128	195.31 kHz
0	1	1	1	0	1	256	97.66 kHz
0	1	1	1	1	0	512	48.83 kHz
0	1	1	1	1	1	1024	24.41 kHz
1	0	0	0	0	0	10	2.5 MHz
1	0	0	0	0	1	20	1.25 MHz
1	0	0	0	1	0	40	625 kHz
1	0	0	0	1	1	80	312.5 kHz
1	0	0	1	0	0	160	156.25 kHz
1	0	0	1	0	1	320	78.13 kHz
1	0	0	1	1	0	640	39.06 kHz

 Table 14-7. Example SPI Baud Rate Selection (25 MHz Bus Clock)



Chapter 18 32 Kbyte Flash Module (S12FTS32KV1)



Figure 18-9. Flash Protection Scenarios

18.3.2.5.1 Flash Protection Restrictions

The general guideline is that protection can only be added, not removed. All valid transitions between Flash protection scenarios are specified in Table 18-12. Any attempt to write an invalid scenario to the FPROT register will be ignored and the FPROT register will remain unchanged. The contents of the FPROT register reflect the active protection scenario.

From	To Protection Scenario ⁽¹⁾								
Scenario	0	1	2	3	4	5	6	7	
0	Х	X	Х	Х					
1		X		Х					
2			Х	X					
3				Х					
4				Х	Х				
5			X	Х	X	Х			

	Table 18-12.	Flash	Protection	Scenario	Transitions
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addresses sequentially staring with 0xFF00-0xFF01 and ending with 0xFF06–0xFF07. The values 0x0000 and 0xFFFF are not permitted as keys. When the KEYACC bit is set, reads of the Flash array will return invalid data.

The user code stored in the Flash array must have a method of receiving the backdoor key from an external stimulus. This external stimulus would typically be through one of the on-chip serial ports.

If KEYEN[1:0] = 1:0 in the FSEC register, the MCU can be unsecured by the backdoor key access sequence described below:

- 1. Set the KEYACC bit in the FCNFG register
- 2. Write the correct four 16-bit words to Flash addresses 0xFF00–0xFF07 sequentially starting with 0xFF00
- 3. Clear the KEYACC bit in the FCNFG register
- 4. If all four 16-bit words match the backdoor key stored in Flash addresses 0xFF00–0xFF07, the MCU is unsecured and bits SEC[1:0] in the FSEC register are forced to the unsecure state of 1:0

The backdoor key access sequence is monitored by the internal security state machine. An illegal operation during the backdoor key access sequence will cause the security state machine to lock, leaving the MCU in the secured state. A reset of the MCU will cause the security state machine to exit the lock state and allow a new backdoor key access sequence to be attempted. The following illegal operations will lock the security state machine:

- 1. If any of the four 16-bit words does not match the backdoor key programmed in the Flash array
- 2. If the four 16-bit words are written in the wrong sequence
- 3. If more than four 16-bit words are written
- 4. If any of the four 16-bit words written are 0x0000 or 0xFFFF
- 5. If the KEYACC bit does not remain set while the four 16-bit words are written

After the backdoor key access sequence has been correctly matched, the MCU will be unsecured. The Flash security byte can be programmed to the unsecure state, if desired.

In the unsecure state, the user has full control of the contents of the four word backdoor key by programming bytes 0xFF00–0xFF07 of the Flash configuration field.

The security as defined in the Flash security/options byte at address 0xFF0F is not changed by using the backdoor key access sequence to unsecure. The backdoor key stored in addresses 0xFF00–0xFF07 is unaffected by the backdoor key access sequence. After the next reset sequence, the security state of the Flash module is determined by the Flash security/options byte at address 0xFF0F. The backdoor key access sequence has no effect on the program and erase protection defined in the FPROT register.

It is not possible to unsecure the MCU in special single chip mode by executing the backdoor key access sequence in background debug mode.



Chapter 19 64 Kbyte Flash Module (S12FTS64KV4)

- Tbus as the period of the bus clock
- INT(x) as taking the integer part of x (e.g., INT(4.323) = 4),

then FCLKDIV register bits PRDIV8 and FDIV[5:0] are to be set as described in Figure 19-24.

For example, if the oscillator clock frequency is 950 kHz and the bus clock is 10 MHz, FCLKDIV bits FDIV[5:0] should be set to 4 (000100) and bit PRDIV8 set to 0. The resulting FCLK is then 190 kHz. As a result, the Flash algorithm timings are increased over optimum target by:

 $(200 - 190)/200 \times 100 = 5\%$

Command execution time will increase proportionally with the period of FCLK.

CAUTION

Because of the impact of clock synchronization on the accuracy of the functional timings, programming or erasing the Flash array cannot be performed if the bus clock runs at less than 1 MHz. Programming or erasing the Flash array with an input clock < 150 kHz should be avoided. Setting FCLKDIV to a value such that FCLK < 150 kHz can destroy the Flash array due to overstress. Setting FCLKDIV to a value such that (1/FCLK + Tbus) < 5 μ s can result in incomplete programming or erasure of the Flash array cells.

If the FCLKDIV register is written, the bit FDIVLD is set automatically. If the FDIVLD bit is 0, the FCLKDIV register has not been written since the last reset. If the FCLKDIV register has not been written to, the Flash command loaded during a command write sequence will not execute and the ACCERR flag in the FSTAT register will set.



Chapter 20 96 Kbyte Flash Module (S12FTS96KV1)

20.4.1.3.4 Mass Erase Command

The mass erase operation will erase all addresses in a Flash array using an embedded algorithm.

An example flow to execute the mass erase operation is shown in Figure 20-27. The mass erase command write sequence is as follows:

- 1. Write to a Flash array address to start the command write sequence for the mass erase command. The address and data written will be ignored.
- 2. Write the mass erase command, 0x41, to the FCMD register.
- 3. Clear the CBEIF flag in the FSTAT register by writing a 1 to CBEIF to launch the mass erase command.

If a Flash array to be erased contains any protected area, the PVIOL flag in the FSTAT register will set and the mass erase command will not launch. Once the mass erase command has successfully launched, the CCIF flag in the FSTAT register will set after the mass erase operation has completed unless a new command write sequence has been buffered.



A.2.2 ATD Operating Characteristics In 3.3V Range

The Table A-11 shows conditions under which the ATD operates.

The following constraints exist to obtain full-scale, full range results: $V_{SSA} \le V_{RL} \le V_{IN} \le V_{RH} \le V_{DDA}$. This constraint exists since the sample buffer amplifier can not drive beyond the power supply levels that it ties to. If the input level goes outside of this range it will effectively be clipped

Conditions are shown in Table A-4 unless otherwise noted; Supply Voltage 3.3V-10% <= V _{DDA} <= 3.3V+10%								
Num	с	Rating	Symbol	Min	Тур	Max	Unit	
1	D	Reference Potential Low High	V _{RL} V _{RH}	V _{SSA} V _{DDA} /2		V _{DDA} /2 V _{DDA}	V V	
2	С	Differential Reference Voltage	$V_{RH}-V_{RL}$	3.0	3.3	3.6	V	
3	D	ATD Clock Frequency	f _{ATDCLK}	0.5	—	2.0	MHz	
4	D	ATD 10-Bit Conversion Period Clock Cycles ⁽¹⁾ Conv, Time at 2.0MHz ATD Clock f _{ATDCLK}	N _{CONV10} T _{CONV10}	14 7		28 14	Cycles μs	
5	D	ATD 8-Bit Conversion Period Clock Cycles ¹ Conv, Time at 2.0MHz ATD Clock f _{ATDCLK}	N _{CONV8} T _{CONV8}	12 6		26 13	Cycles μs	
6	D	Recovery Time (V _{DDA} =3.3 Volts)	t _{REC}	—	_	20	μs	
7	Ρ	Reference Supply current	I _{REF}	_		0.250	mA	

Table A-11. ATD Operating Characteristics

1. The minimum time assumes a final sample period of 2 ATD clocks cycles while the maximum time assumes a final sample period of 16 ATD clocks.

A.2.3 Factors Influencing Accuracy

Three factors — source resistance, source capacitance and current injection — have an influence on the accuracy of the ATD.

A.2.3.1 Source Resistance

Due to the input pin leakage current as specified in Table A-6 in conjunction with the source resistance there will be a voltage drop from the signal source to the ATD input. The maximum source resistance R_S specifies results in an error of less than 1/2 LSB (2.5mV) at the maximum leakage current. If device or operating conditions are less than worst case or leakage-induced error is acceptable, larger values of source resistance is allowable.

A.2.3.2 Source Capacitance

When sampling an additional internal capacitor is switched to the input. This can cause a voltage drop due to charge sharing with the external and the pin capacitance. For a maximum sampling error of the input voltage ≤ 1 LSB, then the external filter capacitor, $C_f \geq 1024 * (C_{INS} - C_{INN})$.